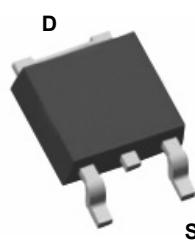
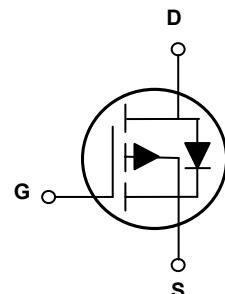


Main Product Characteristics

V_{DS}	-40V
$R_{DS(ON)}$	10mΩ
I_D	-70A



TO-252 (DPAK)



Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The GSFD0471 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	V_{DS}	-40	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	-70	A
Drain Current-Continuous ($T_C=100^\circ\text{C}$)	$I_D(100^\circ\text{C})$	-49.5	A
Pulsed Drain Current	I_{DM}	-200	A
Maximum Power Dissipation	P_D	130	W
Derating Factor		1.04	W/ $^\circ\text{C}$
Single Pulse Avalanche Energy ⁵	E_{AS}	1012	mJ
Thermal Resistance, Junction-to-Case ²	$R_{\theta JC}$	0.96	$^\circ\text{C}/\text{W}$
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To +150	$^\circ\text{C}$

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	V_{DSS}	$V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$	-40	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-40\text{V}$, $V_{GS}=0\text{V}$	-	-	-1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$	-	-	± 100	nA
On Characteristics³						
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$	-1.2	-1.9	-2.5	V
Drain-Source On-State Resistance	$R_{DS(\text{ON})}$	$V_{GS}=-10\text{V}$, $I_D=-20\text{A}$	-	7.5	10	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{DS}=-10\text{V}$, $I_D=-20\text{A}$	-	50	-	S
Dynamic Characteristics⁴						
Input Capacitance	C_{iss}	$V_{DS}=-20\text{V}$, $V_{GS}=0\text{V}$, $f=1.0\text{MHz}$	-	5380	-	PF
Output Capacitance	C_{oss}		-	570	-	PF
Reverse Transfer Capacitance	C_{rss}		-	500	-	PF
Switching Characteristics⁴						
Turn-On Delay Time	$t_{d(on)}$	$V_{DD}=-20\text{V}$, $R_L=2\Omega$ $V_{GS}=-10\text{V}$, $R_G=1\Omega$	-	15	-	nS
Turn-On Rise Time	t_r		-	12	-	nS
Turn-Off Delay Time	$t_{d(off)}$		-	70	-	nS
Turn-Off Fall Time	t_f		-	18	-	nS
Total Gate Charge	Q_g	$V_{DS}=-20\text{V}$, $I_D=-20\text{A}$, $V_{GS}=-10\text{V}$	-	106	-	nC
Gate-Source Charge	Q_{gs}		-	22	-	nC
Gate-Drain Charge	Q_{gd}		-	27	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage ³	V_{SD}	$V_{GS}=0\text{V}$, $I_S=-70\text{A}$	-	-	-1.2	V
Diode Forward Current ²	I_S	$V_{GS}=0\text{V}$, $I_S=-70\text{A}$	-	-	-70	A
Reverse Recovery Time	t_{rr}	$T_J = 25^\circ\text{C}$, $I_F = -70\text{A}$, $di/dt = -100\text{A}/\mu\text{s}$ ³	-	53	-	nS
Reverse Recovery Charge	Q_{rr}		-	50	-	nC
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. Surface Mounted on FR4 Board, $t \leq 10$ sec.

3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.

4. Guaranteed by design

5. E_{AS} condition: $T_J=25^\circ\text{C}$, $V_{DD}=-20\text{V}$, $V_G=-10\text{V}$, $L=1\text{mH}$, $R_g=25\Omega$, $I_{AS}=45\text{A}$

Typical Electrical and Thermal Characteristic Curves

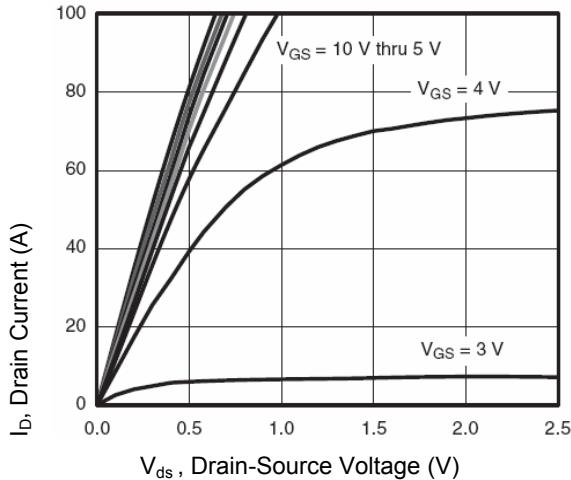


Figure 1. Output Characteristics

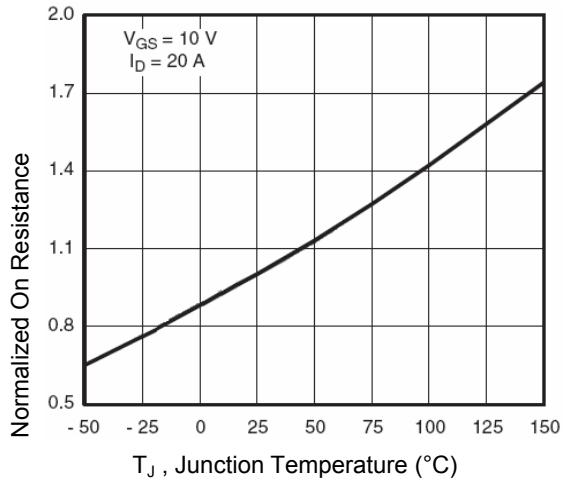


Figure 2. $R_{DS(ON)}$ -Junction Temperature

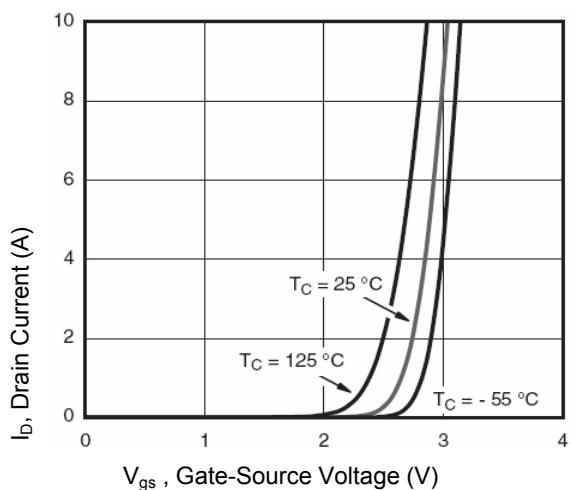


Figure 3. Transfer Characteristics

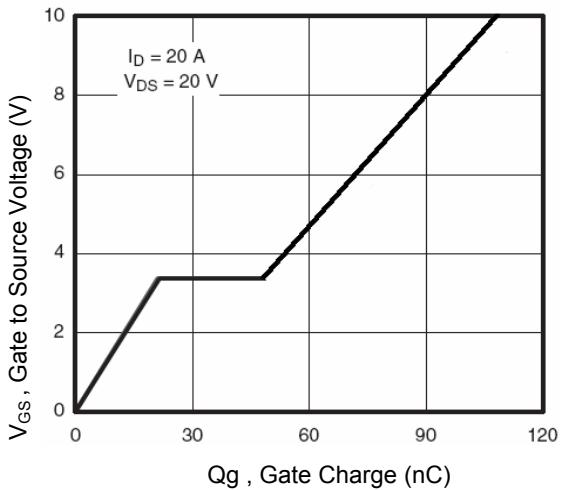


Figure 4. Gate Charge

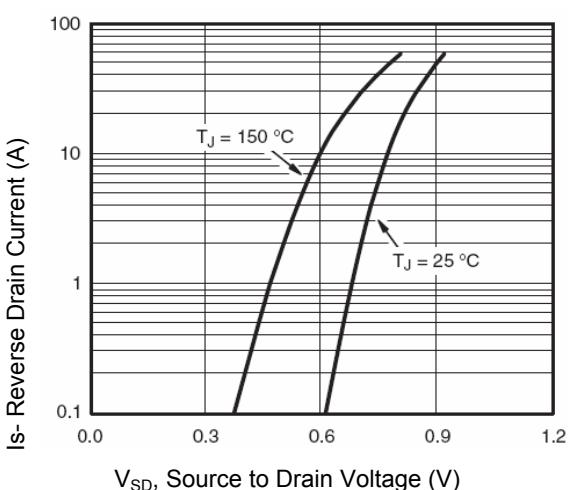


Figure 5. Source-Drain Diode Forward

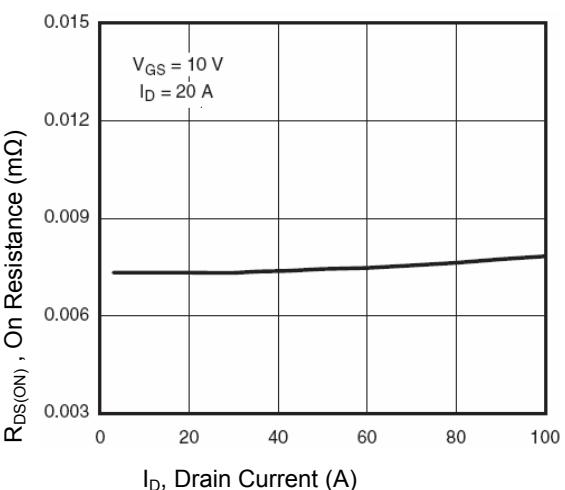


Figure 6. $R_{DS(ON)}$ -Drain Current

Typical Electrical and Thermal Characteristic Curves

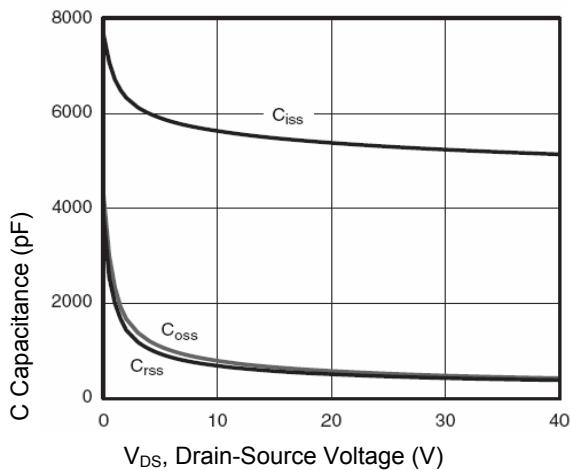


Figure 7. Capacitance vs. V_{DS}

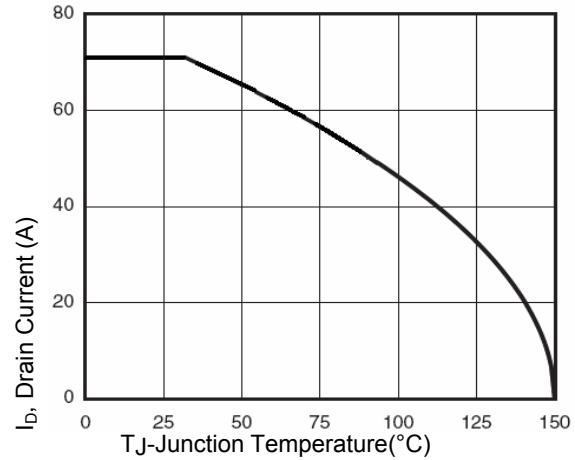


Figure 8. ID Current Derating VS Junction Temperature

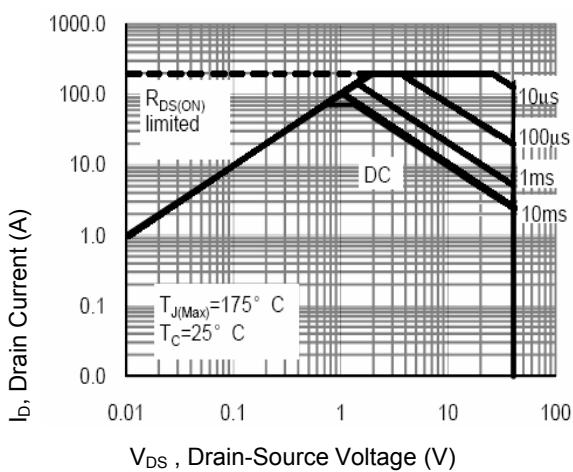


Figure 9. Safe Operation Area

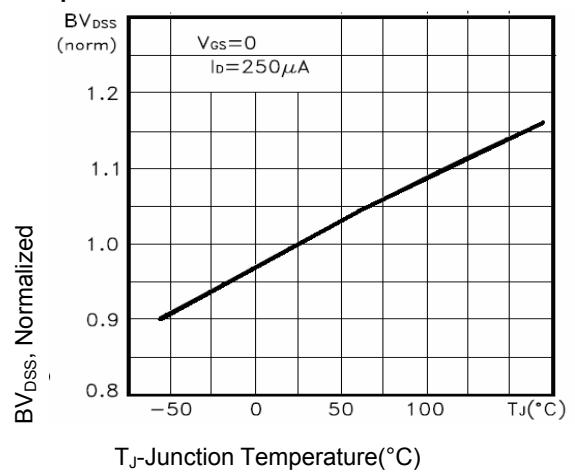


Figure 10. BV_{DSS} vs Junction Temperature

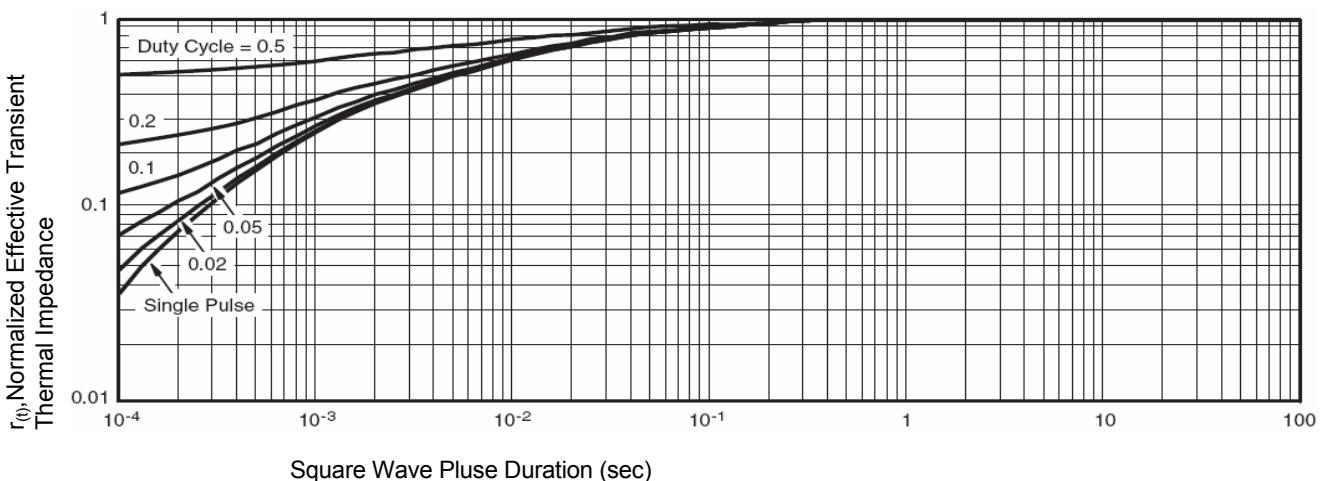


Figure 11. Normalized Maximum Transient Thermal Impedance

Typical Electrical and Thermal Characteristic Curves

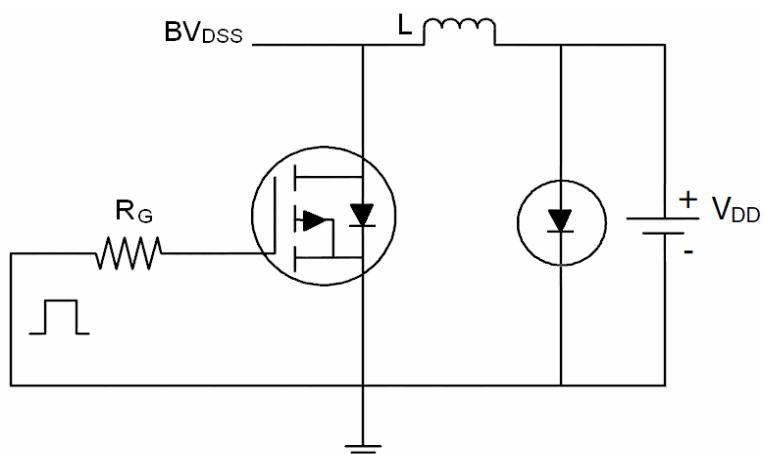


Figure 12. E_{AS} Test Circuit

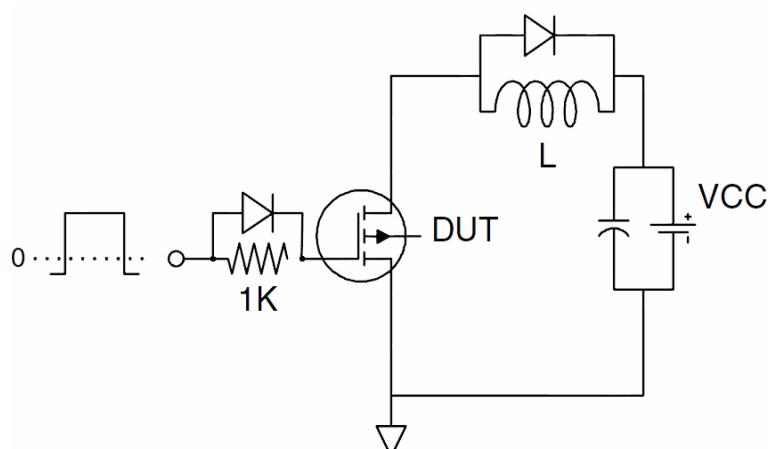


Figure 13. Gate Charge Test Circuit

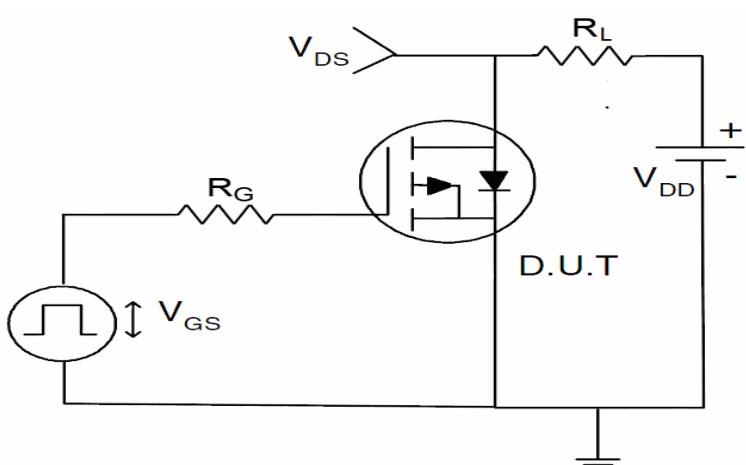
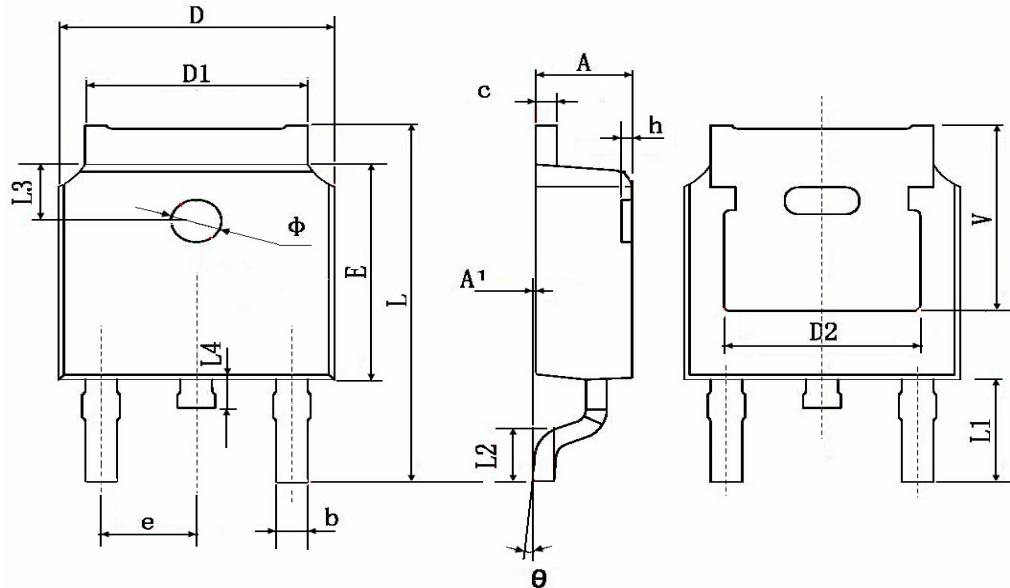


Figure 14. Switch Time Test Circuit

Package Outline Dimensions (TO-252/DPAK)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 TYP.		0.190 TYP.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 TYP.		0.211 TYP.	